

**Notice of References Cited**

Application/Control No.

10/518,418

Applicant(s)/Patent Under  
Reexamination  
BEALE ET AL.

Examiner

Andrew Hwa S. Lee

Art Unit

2886

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,781,293	07-1998	Padgett et al.	356/453
	B	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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